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SERIAL NUMBER 10/750,470	FILING DATE 12/31/2003 RULE	CLASS 438	GROUP ART UNIT 2825	ATTORNEY DOCKET NO. 2522-041	
APPLICANTS Hyo-Cheon Kang, Gyeonggi-do, KOREA, REPUBLIC OF; ** CONTINUING DATA <i>None</i> ** FOREIGN APPLICATIONS <i>Ch</i> REPUBLIC OF KOREA 2003-2599 01/15/2003 IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** 05/01/2004					
Foreign Priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no 35 USC 119 (a-d) conditions met <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance Verified and Acknowledged <i>Carlvent</i> Examiner's Signature Initials		STATE OR COUNTRY KOREA, REPUBLIC OF	SHEETS DRAWING 4	TOTAL CLAIMS 26	INDEPENDENT CLAIMS 4
ADDRESS 20575 MARGER JOHNSON & MCCOLLOM, P.C. 1030 SW MORRISON STREET PORTLAND , OR 97205					
TITLE Method for inspecting a wafer and apparatus for inspecting a wafer					
FILING FEE RECEIVED 964	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:		<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit		